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WHAT IS CLAIMED IS:

- 1. A semiconductor structure, comprising:

 a semiconductor chip; and
- a conductive layer disposed over a portion of the chip, the conductive layer having a portion that extends beyond an edge of the chip.
- 2. The structure of claim 1, wherein the conductive layer comprises a metal line.
- 3. The semiconductor structure of claim 1, wherein the chip comprises a device.
- 4. The semiconductor structure of claim 3, wherein the device comprises an integrated circuit.
- 5. The semiconductor structure of claim 3, wherein the device comprises a microelectromechanical device.
- 6. The semiconductor structure of claim 3, further comprising:

 a contact pad disposed on a surface of said device, wherein a portion of the conductive layer is in electrical communication with said contact pad.
- 14 $\alpha \not b$, c 8. The semiconductor structure of claim 7, wherein the front layer is a dielectric layer.
- 1 りゅうり、こ 9. The semiconductor structure of claim 7, wherein the front layer is compliant.
- 14a, b, C

 The semiconductor structure of claim 7, wherein the front layer includes a bump.

- 11. A semiconductor structure, comprising:

 a semiconductor chip; and

 a semiconductor chip; and

 a front layer, having a first portion disposed on a first surface of the semiconductor chip, and a second portion extending beyond an edge of the chip.
- 12. A method for making a semiconductor structure, comprising: providing a semiconductor chip having a device formed thereon; and forming a layer over a portion of the device, wherein a portion of the layer extends beyond an outer edge of the device.
- 13. The method of claim 12, wherein the layer is a conductive layer.
- 14. The method of claim 13, further comprising: defining a line in the conductive layer.
- 15. The method of claim 13, further comprising: forming a front layer having a first portion disposed on a first surface of the device, and a second portion extending beyond the edge of the device, the conductive layer being disposed on the front layer.
- 16. The method of claim 13, wherein the device is formed proximate a first surface of the chip, further comprising:

forming an encapsulating layer proximate a second surface of the chip, wherein the portion of the front layer extending beyond the outer edge of the device extends over the encapsulating layer.

17. A method for making a semiconductor structure, comprising:

providing a plurality of semiconductor chips; and

forming a first encapsulating layer between each of the semiconductor chips,

wherein the encapsulating layer bonds the chips together.



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The method of claim 16, further comprising: 18.

forming a second encapsulating layer over the backside of the chips.